**IRFN340** 

# International Rectifier

# POWER MOSFET SURFACE MOUNT(SMD-1)

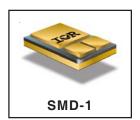
JANTX2N7221U JANTXV2N7221U REF:MIL-PRF-19500/596 400V, N-CHANNEL

**HEXFET® MOSFET TECHNOLOGY** 

**Product Summary** 

| Part Number | RDS(on) | ID  |  |
|-------------|---------|-----|--|
| IRFN340     | 0.55 Ω  | 10A |  |

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.



#### Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

## **Absolute Maximum Ratings**

|  | Parameter                            |                    | Units |
|--|--------------------------------------|--------------------|-------|
| ID @ VGS = 10V, TC = 25°C              | Continuous Drain Current             | 10                 |       |
| ID @ VGS = 10V, TC = 100°C             | Continuous Drain Current             | 6.0                | Α     |
| IDM Pulsed Drain Current ①             |                                      | 40                 |       |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C | Max. Power Dissipation               | 125                | W     |
|  | Linear Derating Factor               | 1.0                | W/°C  |
| VGS                                    | Gate-to-Source Voltage               | ±20                | V     |
| EAS                                    | Single Pulse Avalanche Energy ②      | 650                | mJ    |
| IAR Avalanche Current ①                |                                      | 10                 | Α     |
| EAR                                    | Repetitive Avalanche Energy ①        | 12.5               | mJ    |
| dv/dt                                  | Peak Diode Recovery dv/dt 3          | 4.0                | V/ns  |
| TJ                                     | Operating Junction                   | -55 to 150         |       |
| TSTG                                   | Storage Temperature Range            |                    | °C    |
|  | Package Mounting Surface Temperature | 300(for 5 seconds) |       |
|  | Weight                               | 2.6 (Typical)      | g     |

For footnotes refer to the last page

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# Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

| Electrical Gridiant Cristics & 1) = 20 0 (Onless Otherwise Openheu) |  |     |      |      |       |  |  |
|---|--|-----|------|------|-------|--|--|
|   | Parameter                                    | Min | Тур  | Max  | Units | Test Conditions  |  |
| BVDSS   | Drain-to-Source Breakdown Voltage            | 400 | _    | _    | V     | VGS = 0V, ID = 1.0mA                                       |  |
| ΔBVDSS/ΔTJ  | Temperature Coefficient of Breakdown Voltage | _   | 0.46 | _    | V/°C  | Reference to 25°C, I <sub>D</sub> = 1.0mA                  |  |
| RDS(on)   | Static Drain-to-Source On-State              | _   | _    | 0.55 | Ω     | VGS = 10V, ID = 6.0A                                       |  |
| , ,   | Resistance                                   | _   | _    | 0.70 | 22    | VGS = 10V, ID = 10A  |  |
| VGS(th)   | Gate Threshold Voltage                       | 2.0 | _    | 4.0  | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA |  |
| 9fs   | Forward Transconductance                     | 4.9 | _    | _    | S     | V <sub>DS</sub> =15V, I <sub>DS</sub> = 6.0A 4             |  |
| IDSS  | Zero Gate Voltage Drain Current              | _   | _    | 25   | μΑ    | VDS= 320V ,VGS=0V  |  |
|   |  | _   | —    | 250  | μΛ    | $V_{DS} = 320V$ ,  |  |
|   |  |     |      |      |       | $V_{GS} = 0V, T_{J} = 125^{\circ}C$                        |  |
| lgss  | Gate-to-Source Leakage Forward               | _   | _    | 100  | nA    | VGS = 20V  |  |
| IGSS  | Gate-to-Source Leakage Reverse               | _   | _    | -100 | IIA   | V <sub>GS</sub> = -20V                                     |  |
| Qg  | Total Gate Charge                            |     | _    | 65   |       | VGS =10V, ID = 10A   |  |
| Qgs   | Gate-to-Source Charge                        | _   | _    | 14   | nC    | V <sub>DS</sub> = 200V                                     |  |
| Q <sub>gd</sub>   | Gate-to-Drain ('Miller') Charge              | _   | _    | 40.5 |       |  |  |
| <sup>t</sup> d(on)  | Turn-On Delay Time                           | _   | _    | 25   |       | $V_{DD} = 200V, I_D = 10A,$                                |  |
| t <sub>r</sub>  | Rise Time                                    | _   | _    | 92   | ns    | $V_{GS} = 10V$ , $R_{G} = 2.35\Omega$                      |  |
| <sup>t</sup> d(off)   | Turn-Off Delay Time                          | _   | _    | 79   | 115   |  |  |
| tf  | Fall Time                                    | _   | _    | 58   |       |  |  |
| LS+LD   | Total Inductance                             | _   | 4.0  | _    | nH    | Measured from the center of drain                          |  |
|   |  |     |      |      |       | pad to center of source pad.                               |  |
| Ciss  | Input Capacitance                            | _   | 1400 |      |       | $V_{GS} = 0V$ , $V_{DS} = 25V$                             |  |
| Coss  | Output Capacitance                           | _   | 3500 | _    | pF    | f = 1.0MHz   |  |
| C <sub>rss</sub>  | Reverse Transfer Capacitance                 | _   | 2300 | _    |       |  |  |

# **Source-Drain Diode Ratings and Characteristics**

|     | Parameter   |   | Min | Тур | Max | Units                                       | Test Conditions                              |
|-----|---|---|-----|-----|-----|---|--|
| Is  | IS Continuous Source Current (Body Diode) ISM Pulse Source Current (Body Diode) ① |   | _   | _   | 10  | Α   |  |
| ISM |   |   | _   | _   | 40  |   |  |
| VsD | Diode Forward Voltage   |   | _   | _   | 1.5 | V   | $T_j = 25$ °C, $I_S = 10A$ , $V_{GS} = 0V$ ④ |
| trr | Reverse Recovery Time R Reverse Recovery Charge                                   |   | _   | _   | 600 | ns  | Tj = 25°C, IF = 10A, di/dt ≤ 100A/μs         |
| QRR |   |   | _   | _   | 5.6 | μC  | V <sub>DD</sub> ≤ 30V ④                      |
| ton | Forward Turn-On Time  | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by LS |     |     |     | eed is substantially controlled by LS + LD. |  |

# **Thermal Resistance**

|                      | Parameter            | Min | Тур | Max | Units  | Test Conditions                    |
|----------------------|----------------------|-----|-----|-----|--------|------------------------------------|
| RthJC                | Junction-to-Case     | _   | _   | 1.0 | °C/W   |                                    |
| R <sub>thJ-PCB</sub> | Junction-to-PC board | _   | 4.0 | _   | . C/VV | Soldered to a copper-clad PC board |

Note: Corresponding Spice and Saber models are available on International Rectifier Web site.

For footnotes refer to the last page

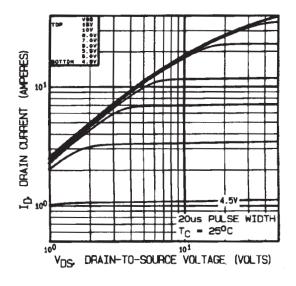


Fig 1. Typical Output Characteristics

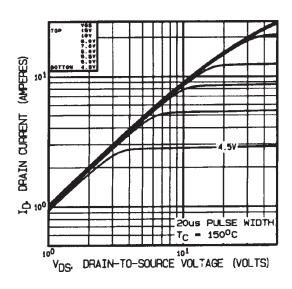


Fig 2. Typical Output Characteristics

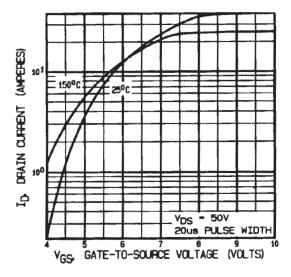
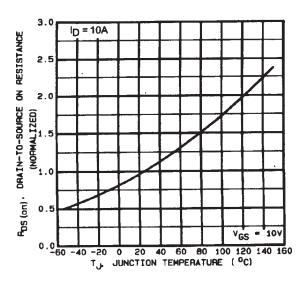
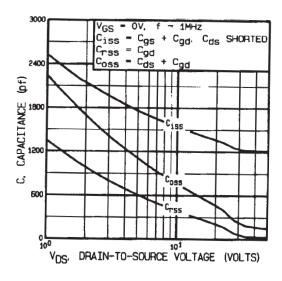


Fig 3. Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature

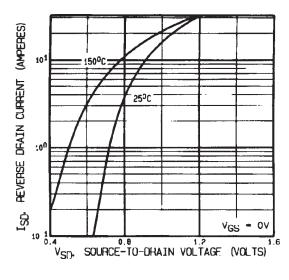


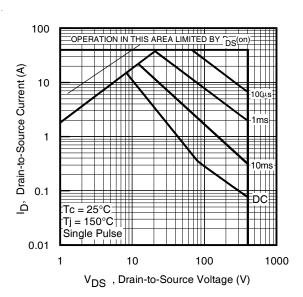
O 15 30 45 60 75

Qg. TOTAL GATE CHARGE (nC)

**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

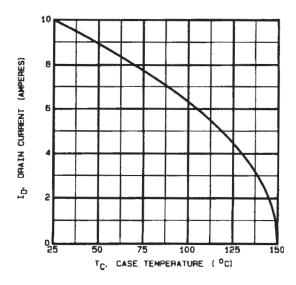
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage





**Fig 7.** Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature

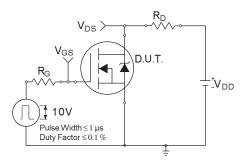


Fig 10a. Switching Time Test Circuit

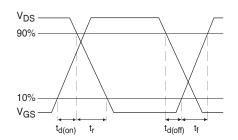


Fig 10b. Switching Time Waveforms

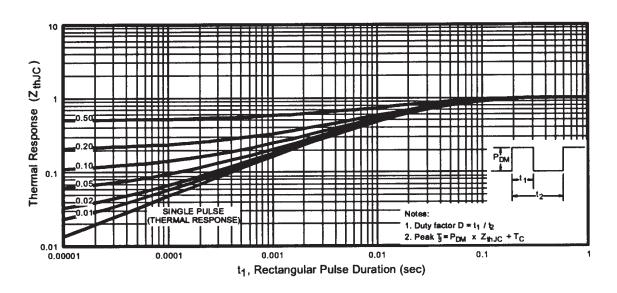


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

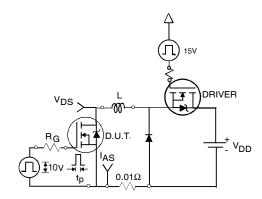


Fig 12a. Unclamped Inductive Test Circuit

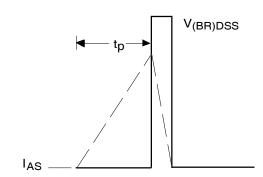


Fig 12b. Unclamped Inductive Waveforms

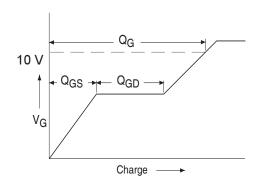


Fig 13a. Basic Gate Charge Waveform

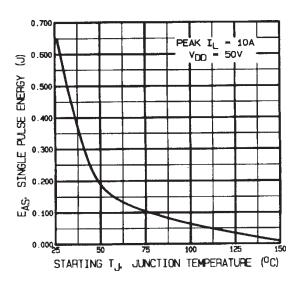


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

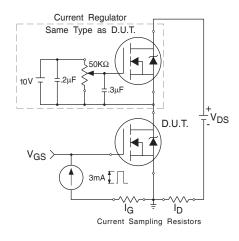


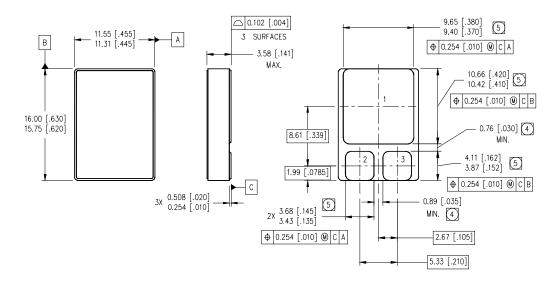
Fig 13b. Gate Charge Test Circuit

**IRFN340** 

### Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$  V<sub>DD</sub> = 50V, starting T<sub>J</sub> = 25°C, L= 13mH Peak I<sub>L</sub> = 10A, V<sub>GS</sub> = 10V
- $\text{ $ \text{ISD} \leq 10$A, $di/dt \leq 120$A/$\mu$s,} \\ \text{$ \text{VDD} \leq 400$V, $T_J \leq 150$°C}$
- ④ Pulse width ≤ 300  $\mu$ s; Duty Cycle ≤ 2%

### Case Outline and Dimensions — SMD-1



#### NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- (4) DIMENSION INCLUDES METALLIZATION FLASH.
- 5) DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

#### **PADASSIGNMENTS**

- 1- DRAIN
- 2- GATE
- 3- SOURCE

# International Rectifier

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>>Infineon Technologies(英飞凌)